



ESD204 4-Channel Low-Capacitance Surge and ESD Protection Diode

1 Features

- IEC 61000-4-2 Level 4 ESD Protection
 - ± 30 -kV Contact Discharge
 - ± 30 -kV Air Gap Discharge
- IEC 61000-4-4 EFT Protection
 - 80 A (5/50 ns)
- IEC 61000-4-5 Surge Protection
 - 5.5 A (8/20 μ s)
 - Low Surge Clamping Voltage
8.5 V at 5.5 A I_{PP}
- IO Capacitance:
 - 0.55 pF (Typical)
- HDMI 2.0 Compliant
- DC Breakdown Voltage: 5.5 V (Minimum)
- Ultra Low Leakage Current: 10 nA (Maximum)
- Supports High Speed Interfaces up to 6 Gbps
- Industrial Temperature Range: -40°C to $+125^{\circ}\text{C}$
- Easy Flow-Through Routing Package

2 Applications

- End Equipment
 - IP Network Camera
 - DVR and NVR
 - Ethernet Switches and Routers
 - Laptops and Desktops
 - Set-Top Boxes
 - TV and Monitors
 - Mobile and Tablets
- Interfaces
 - HDMI 2.0
 - HDMI 1.4
 - USB 3.0
 - Display Port 1.3
 - PCI Express 3.0
 - Ethernet 10/100/1000 Mbps

3 Description

The ESD204 is a bidirectional TVS ESD protection diode array for HDMI and USB surge protection up to 5.5 A (8/20 μ s). The ESD204 is rated to dissipate ESD strikes at the maximum level specified in the IEC 61000-4-2 international standard (Level 4).

The low clamping and high differential bandwidth provided by ESD204 enables the device to cleanly pass high speed signals while providing robust protection to downstream devices. This device has a low capacitance of 0.55-pF per channel making it suitable for protecting high-speed interfaces up to 6 Gbps such as HDMI 2.0, HDMI 1.4, USB 3.0 and Ethernet 1G. The low dynamic resistance and low clamping voltage ensure system level protection against transient events.

The ESD204 is offered in the industry standard USON-10 (DQA) package. The package features flow-through routing and 0.5-mm pin pitch easing implementation and reducing design time.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
ESD204	USON (10)	2.50 mm x 1.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Typical Application Schematic

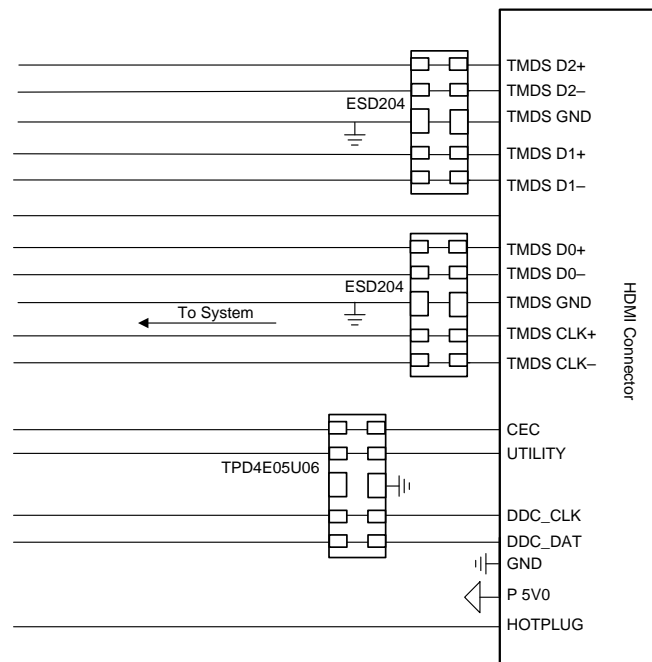


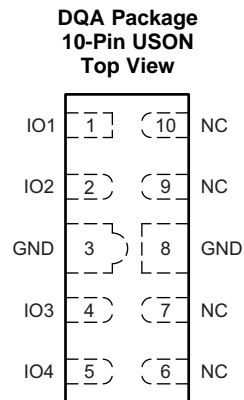
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4 Revision History

Changes from Original (February 2018) to Revision A	Page
• Changed from Advance Information to Production Data	1

5 Pin Configuration and Functions



Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.		
GND	3	Ground	Ground. Connect to ground
GND	8		
IO1	1	I/O	ESD protected channel. Connect to the line being protected.
IO2	2		
IO3	4		
IO4	5		
NC	6	NC	Not connected internally; Can be connected to line being protected for optional flow-through routing. Can also be left floating or grounded
NC	7		
NC	9		
NC	10		

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Electrical Fast Transient	IEC 61000-4-4 Peak Current at 25°C		80	A
Peak Pulse	IEC 61000-4-5 Surge (t_p 8/20 μ s) Peak Power at 25°C		50	W
	IEC 61000-4-5 Surge (t_p 8/20 μ s) Peak Current at 25°C		5.5	A
T_A	Operating free-air temperature	-40	125	°C
T_{stg}	Storage temperature	-65	155	°C

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings -JEDEC Specifications

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2500	V
	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 ESD Ratings - IEC Specifications

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	IEC 61000-4-2 Contact Discharge, all pins	±30000	V
	IEC 61000-4-2 Air Discharge, all pins	±30000	

6.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{IN}	Input voltage	-3.6		3.6	V
T_A	Operating Free Air Temperature	-40		125	°C

6.5 Thermal Information

THERMAL METRIC ⁽¹⁾		ESD204	UNIT
		DQA (USON)	
		10 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	262.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	184.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	138.2	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	41.8	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	137.8	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.6 Electrical Characteristics

At $T_A = 25^\circ\text{C}$ unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	$I_{IO} < 10\text{ nA}$, across operating temperature range	-3.6		3.6	V
V_{BRF}	Positive Breakdown Voltage, Each IO Pin to GND ⁽¹⁾	$I_{IO} = 1\text{ mA}$	5		7.9	V
V_{BRR}	Negative Breakdown Voltage, Each IO Pin to GND ⁽¹⁾	$I_{IO} = -1\text{ mA}$,	-7.9		-5	V
V_{HOLD}	Positive Holding Voltage, Each IO pin to GND ⁽²⁾	$I_{IO} = 1\text{ mA}$		6.2		V
$V_{HOLD-NEG}$	Negative Holding Voltage, Each IO pin to GND ⁽²⁾	$I_{IO} = -1\text{ mA}$		-6.2		V
V_{CLAMP}	Clamping voltage	Surge $I_{PP} = 5.5\text{ A}$, Each IO pin to GND, GND to Each IO pin, $t_p=8/20\text{ }\mu\text{s}$		8.5		V
		TLP $I_{PP} = 5\text{ A}$, Each IO pin to GND, GND to Each IO pin, $t_p=10/100\text{ ns}$		8.2		V
		TLP $I_{PP} = 16\text{ A}$, Each IO pin to GND, GND to Each IO pin, $t_p=10/100\text{ ns}$		11.5		V
R_{DYN}	Dynamic resistance	Each IO Pin to GND, TLP $t_p=10/100\text{ ns}$		0.3		Ω
		GND to Each IO Pin, TLP $t_p=10/100\text{ ns}$		0.3		
C_{LINE}	Line capacitance, any IO to GND	$V_{IO} = 0\text{ V}$, $V_{p-p} = 30\text{ mV}$, $f = 1\text{ MHz}$		0.55	0.65	pF
ΔC_{LINE}	Variation of line capacitance	$C_{LINE1} - C_{LINE2}$, $V_{IO} = 0\text{ V}$, $V_{p-p} = 30\text{ mV}$, $f = 1\text{ MHz}$		0.02	0.07	pF
C_{CROSS}	Line-to-line capacitance	$V_{IO} = 0\text{ V}$, $V_{rms} = 30\text{ mV}$, $f = 1\text{ MHz}$		0.25	0.35	pF

(1) V_{BRF} and V_{BRR} are defined as the voltage obtained at 1 mA when sweeping the voltage up, before the device latches into the snapback state

(2) V_{HOLD} is defined as the voltage when 1 mA is applied, after the device has successfully latched into the snapback state.

6.7 Typical Characteristics

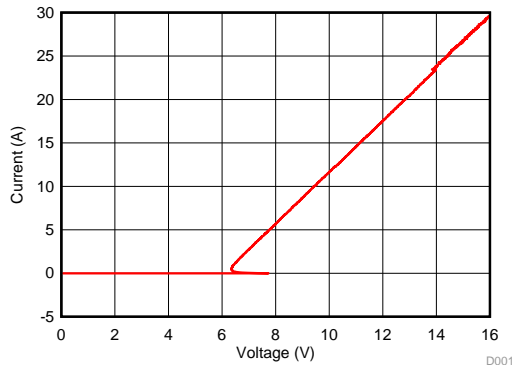


Figure 1. Positive TLP Curve, IO pin to GND ($t_p = 100$ ns)

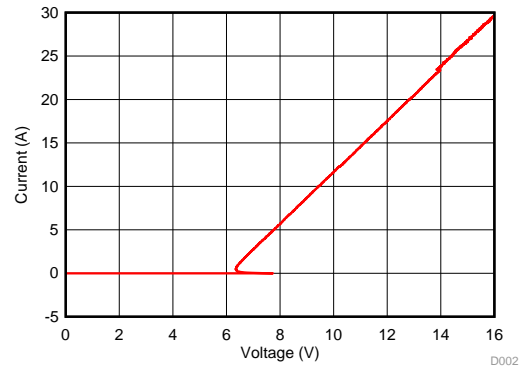


Figure 2. Negative TLP Curve, GND to IO pin ($t_p=100$ ns; Plotted as Positive TLP Curve from GND to IO pin)

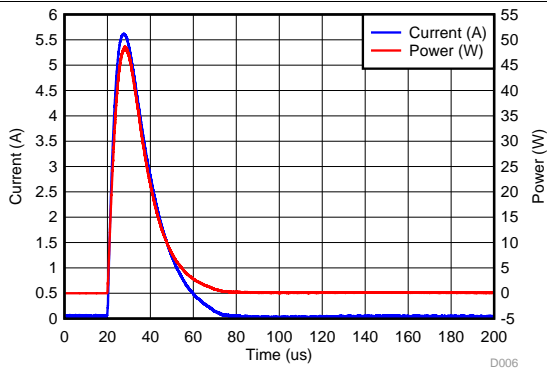


Figure 3. Surge Curve ($t_p = 8/20$ μ s), any IO pin to GND

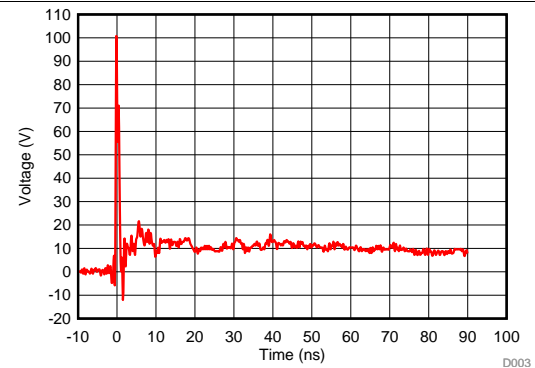


Figure 4. 8-kV IEC 61000-4-2 Clamping Voltage Waveform, IO pin to GND

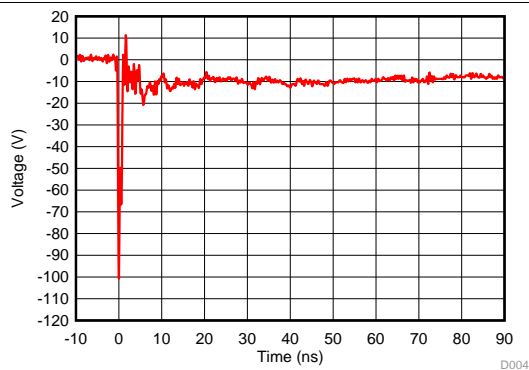


Figure 5. -8-kV IEC 61000-4-2 Clamping Voltage Waveform, GND pin to IO

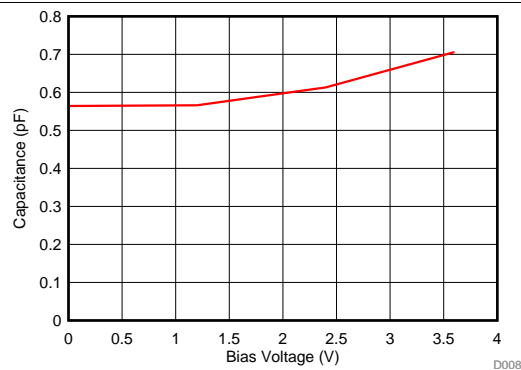


Figure 6. Capacitance vs Bias Voltage

Typical Characteristics (continued)

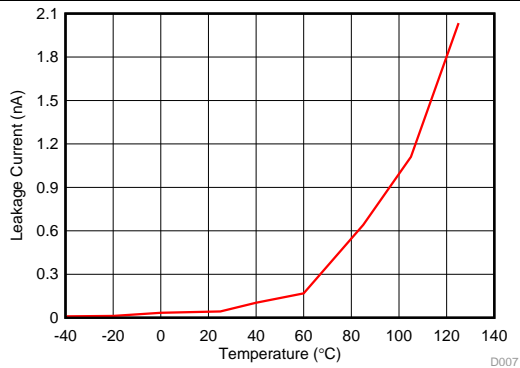


Figure 7. Leakage Current vs Temperature, IO pin to GND at 3.6 V Bias

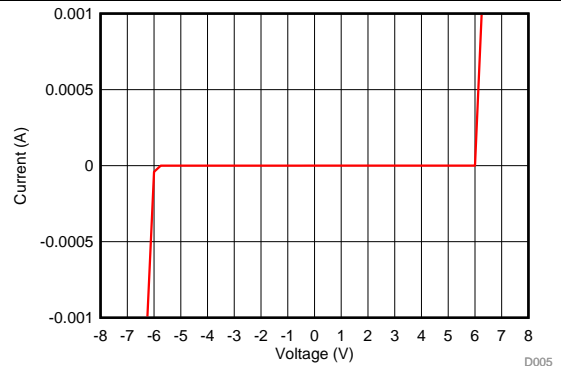


Figure 8. DC Voltage Sweep I-V Curve, IO pin to GND

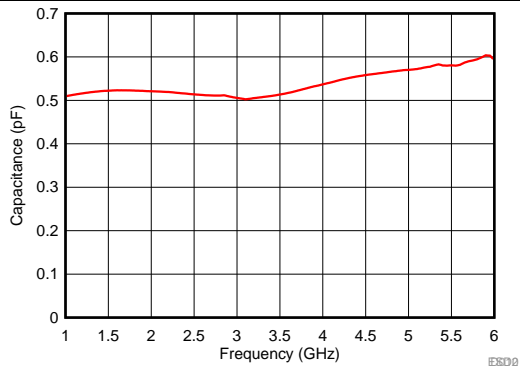


Figure 9. Capacitance vs Frequency

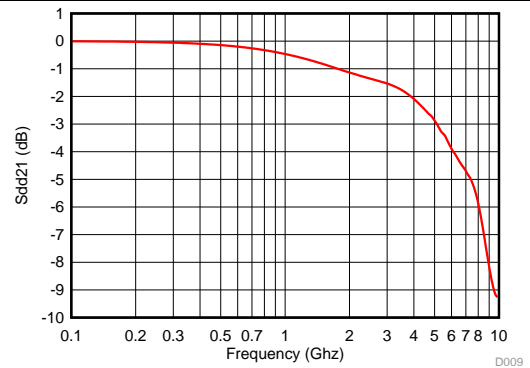


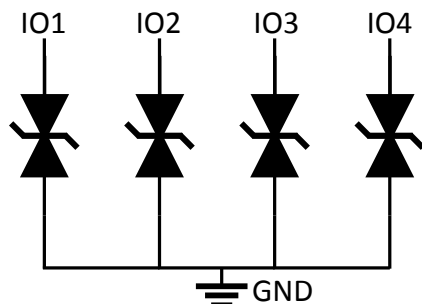
Figure 10. Differential Insertion Loss

7 Detailed Description

7.1 Overview

The ESD204 is a bidirectional ESD Protection Diode with ultra-low capacitance. This device can dissipate ESD strikes up to 30kV (Contact/Air) level specified by the IEC 61000-4-2 International Standard. Additionally, ESD204 dissipates 5.5 A of surge current (8/20 μ s waveform) per IEC 61000-4-5 standard. The ultra-low capacitance makes this device capable of supporting any super high-speed signal pins.

7.2 Functional Block Diagram



7.3 Feature Description

ESD204 provides ESD protection up to ± 30 -kV contact and ± 30 -kV air gap per IEC61000-4-2 standard. During an ESD event, ESD diode connected to the IO pin turns on and diverts the ESD current to ground. Additionally, ESD204 also provides protection against IEC 61000-4-5 surge currents up to 5.5 A (8/20 μ s waveform) and up to 80 A per IEC 61000-4-4 electrical fast transient (EFT) standard. Please see the [Application Note](#) on IEC61000-4-x standard based tests. ESD204 provides a very low clamping voltage of 11.5 V at 16 A 100 ns TLP current and 8.5 V at 5.5 A surge current (8/20 μ s waveform).

The capacitance between each I/O pin to ground is 0.55 pF (typical) and 0.65 pF (maximum). This device supports data rates up to 6 Gbps. The DC breakdown voltage of each I/O pin is a minimum of ± 5 V. This ensures that sensitive equipment is protected from surges above the reverse standoff voltage of ± 3.6 V. The I/O pins feature an ultra-low leakage current of 10 nA (maximum) with a bias of ± 3.6 V.

7.4 Device Functional Modes

The ESD204 is a passive integrated circuit that triggers when voltages are above V_{BRF} or below V_{BRR} . During ESD events, voltages as high as ± 30 kV (contact/air) can be directed to ground via the internal diode network. When the voltages on the protected line fall below the trigger levels of ESD204 (usually within 10s of nano-seconds) the device reverts to passive.

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The ESD204 is a diode type TVS array which is used to provide a path to ground for dissipating ESD events on high-speed signal lines between an interface connector and a system. As the current from ESD passes through the TVS, only a small voltage drop is present across the diode. This is the voltage presented to the protected IC. The low R_{DYN} of the triggered TVS holds this voltage, V_{CLAMP} , to a safe level for the protected IC.

8.2 Typical Application

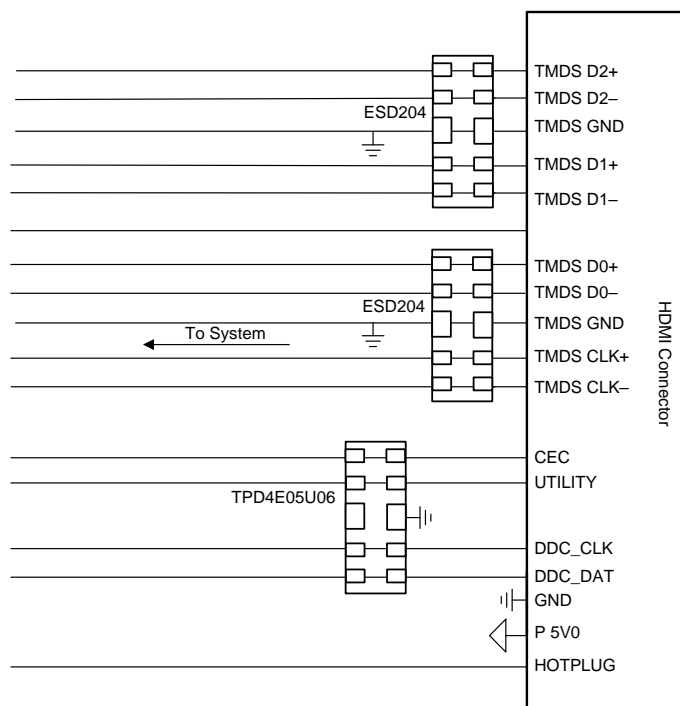


Figure 11. ESD204 Protecting the HDMI Interface

8.2.1 Design Requirements

In this design example, two ESD204 devices and one TPD4E05U06 device are used to protect an HDMI 2.0 interface. For HDMI 2.0 application design parameters listed in Table 1 are known.

Table 1. Design Parameters

DESIGN PARAMETER	VALUE
Signal range on high speed differential data lines	0 to 3.6 V
Operating frequency of high speed data lines	3 GHz (First Harmonic)
Signal range on control lines (CEC, UTILITY, DDC_CLK and DDC_DAT)	0 to 5 V

8.2.2 Detailed Design Procedure

8.2.2.1 Signal Range

ESD204 supports signal ranges between -3.6 V and 3.6 V , which supports the high-speed lines on the HDMI 2.0 application. The TPD4E05U06 supports signal ranges between 0 V and 5.5 V , which supports the HDMI control lines.

8.2.2.2 Operating Frequency

The ESD204 has a 0.55 pF (typical) capacitance, which supports the HDMI 2.0 rate of 6 Gbps . The TPD4E05U06 has a typical capacitance of 0.5 pF , which easily support the control lines. The ESD204 has 4 identical protection channels for the differential HDMI high-speed signal lines. The symmetrical pin out of the device with a ground pin between the two differential signal pins makes it suitable for this application.

8.2.3 Application Curves

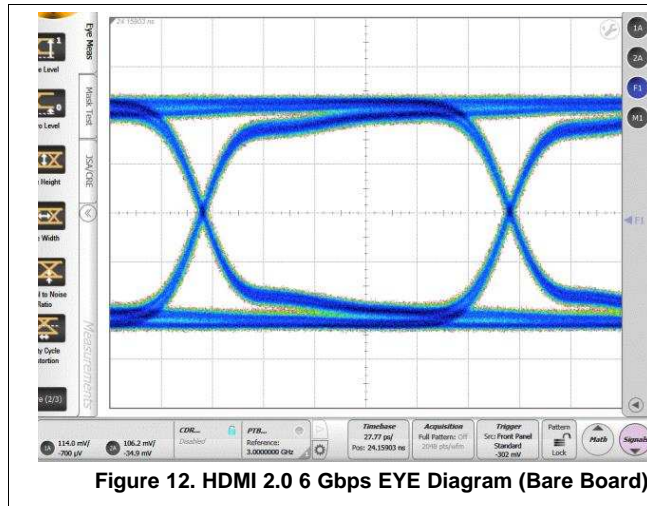


Figure 12. HDMI 2.0 6 Gbps EYE Diagram (Bare Board)

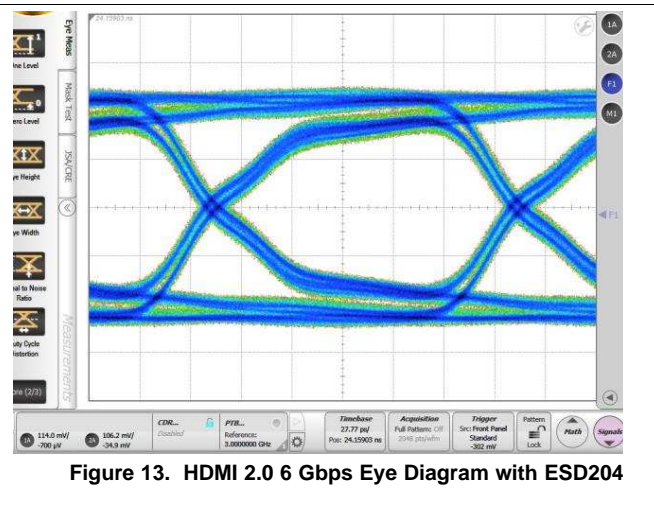


Figure 13. HDMI 2.0 6 Gbps Eye Diagram with ESD204

9 Power Supply Recommendations

This device is a passive ESD device so there is no need to power it. Take care not to violate the recommended I/O specification (–3.6 V to 3.6 V) to ensure the device functions properly.

10 Layout

10.1 Layout Guidelines

- The optimum placement is as close to the connector as possible.
 - EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures.
 - The PCB designer must minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.
- Route the protected traces as straight as possible.
- Eliminate any sharp corners on the protected traces between the TVS and the connector by using rounded corners with the largest radii possible.
 - Electric fields tend to build up on corners, increasing EMI coupling.

10.2 Layout Examples

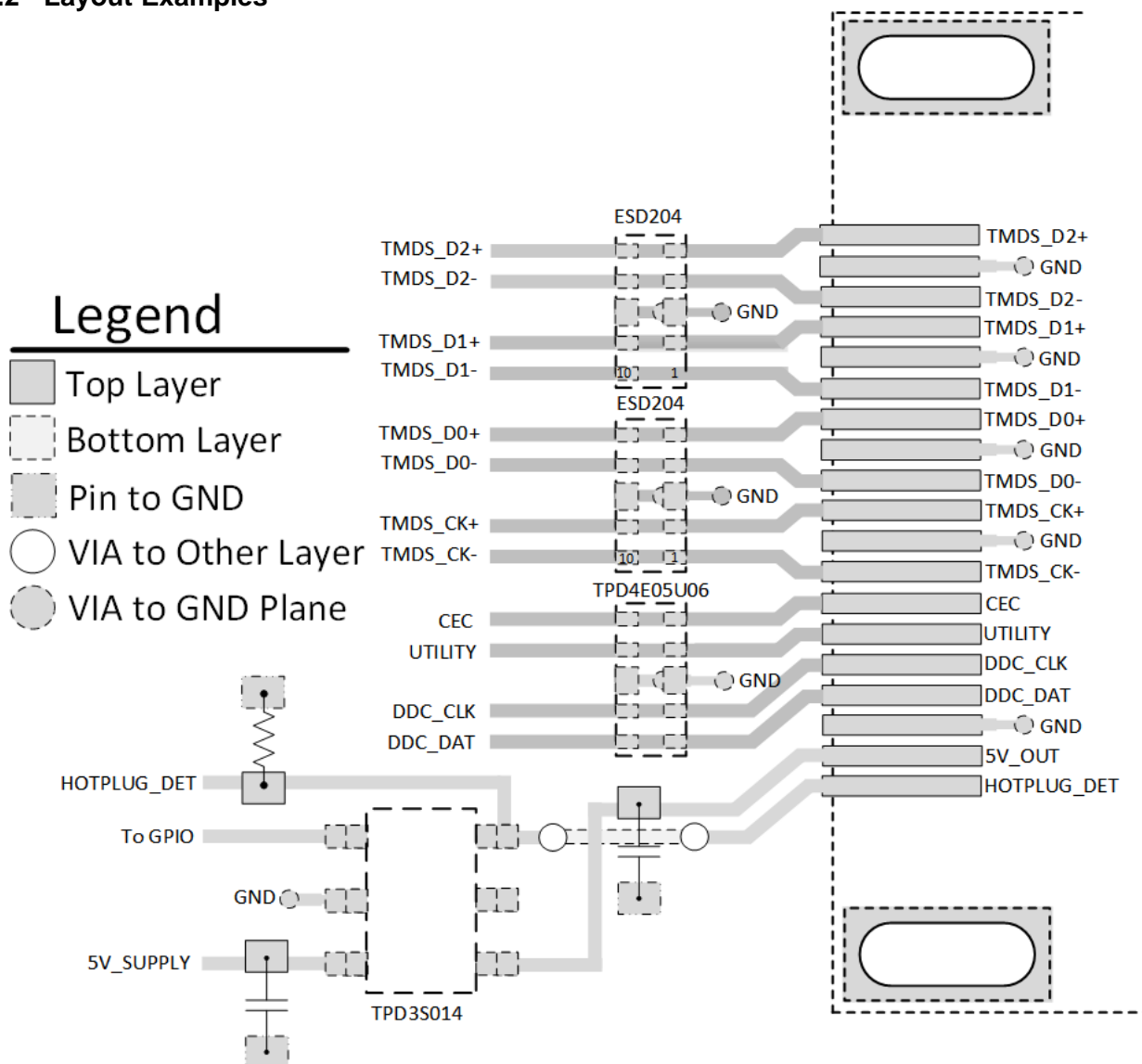


Figure 14. HDMI Type-A Transmitter Port Layout

11 Device and Documentation Support

11.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.3 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

11.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.5 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
ESD204DQAR	ACTIVE	USON	DQA	10	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CEG CEY	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

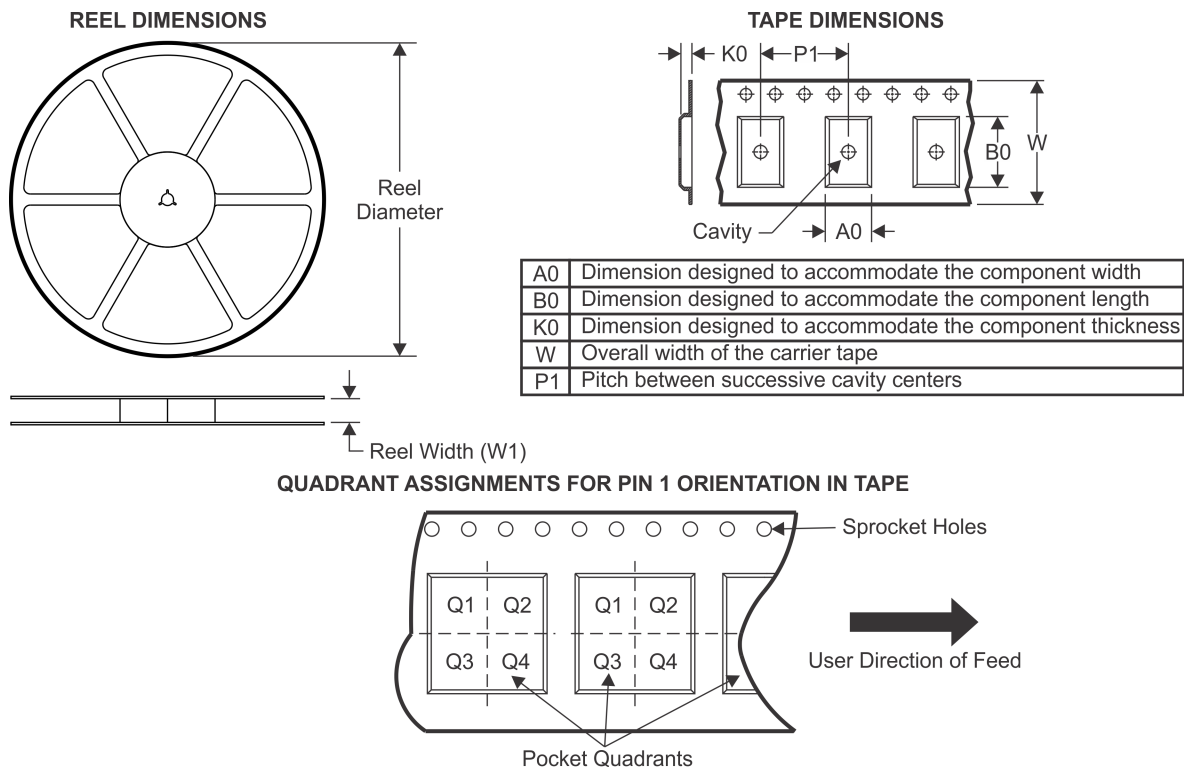
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ESD204DQAR	USON	DQA	10	3000	180.0	8.4	1.23	2.7	0.6	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS

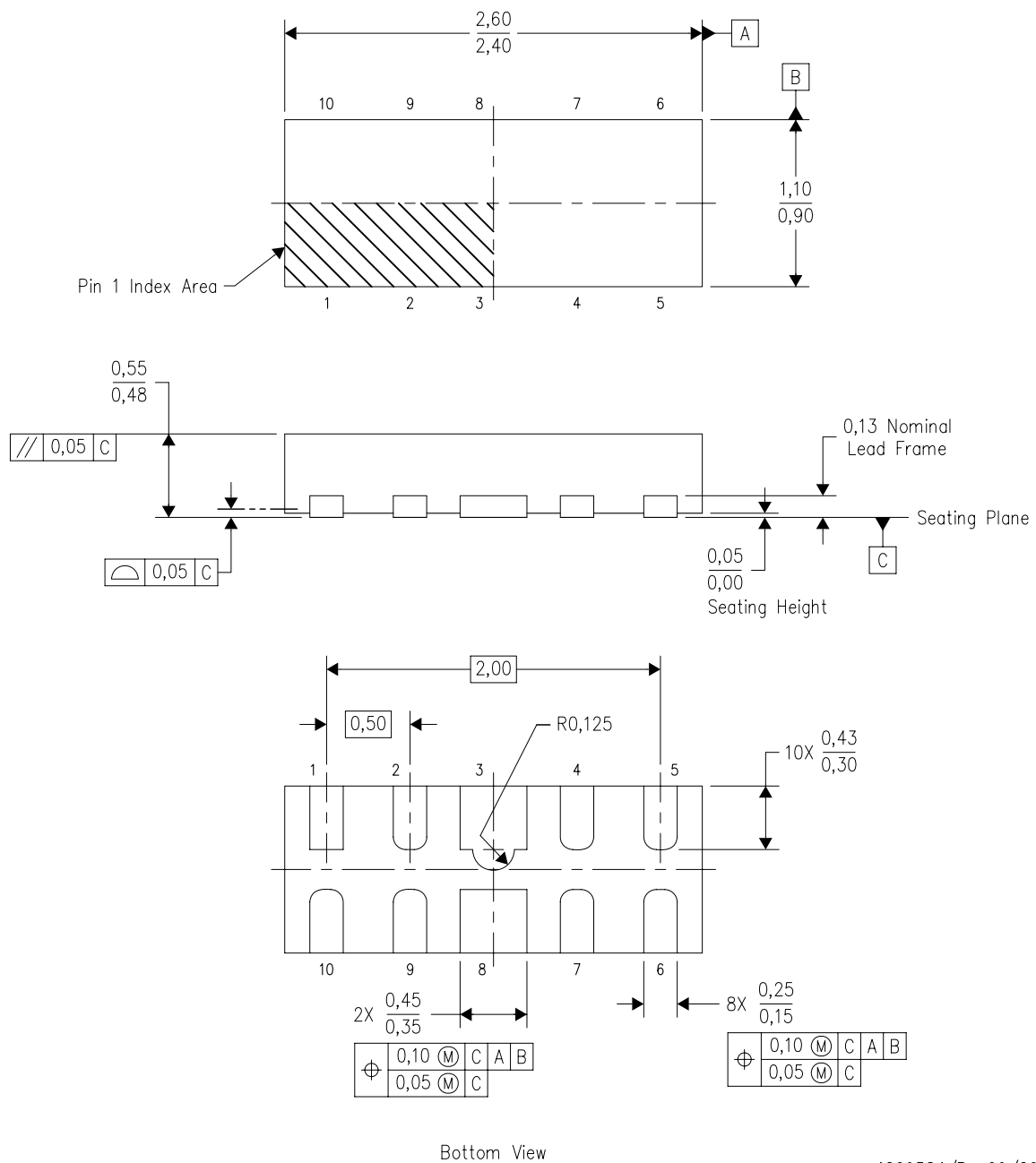


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ESD204DQAR	USON	DQA	10	3000	203.2	196.8	33.3

DQA (R-PSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD

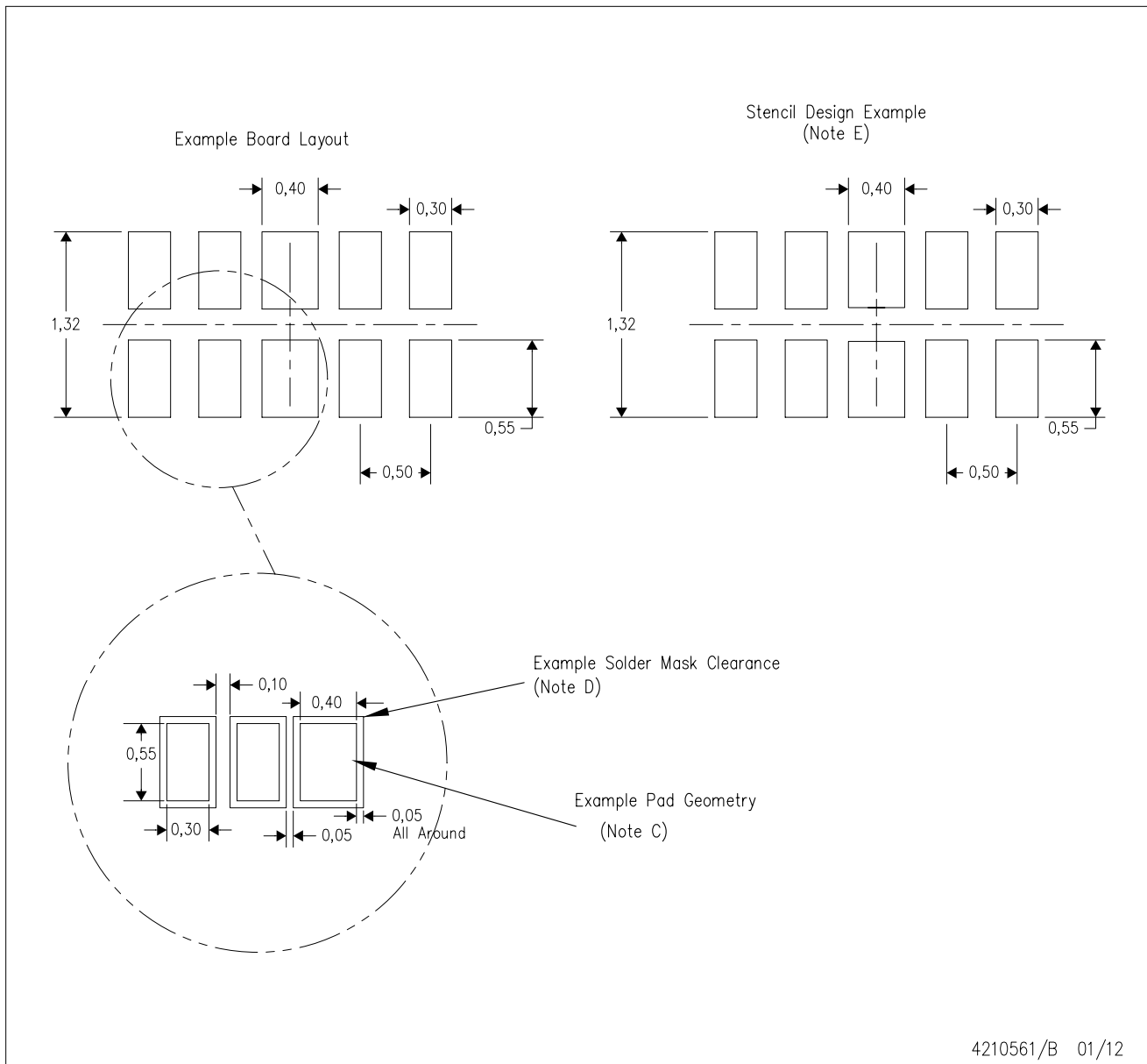


4209584/B 09/2009

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. SON (Small Outline No-Lead) package configuration.

DQA (R-PUSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
 - E. Maximum stencil thickness 0,127 mm (5 mils). All linear dimensions are in millimeters.
 - F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - G. Side aperture dimensions over-print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.

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